

## HEXFET® Power MOSFET

### KRF7507

#### ■ Features

- Generation V Technology

- Ultra Low On-Resistance

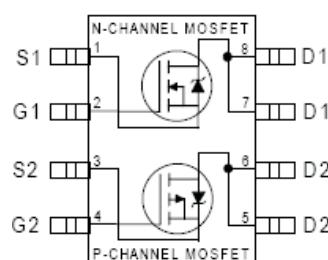
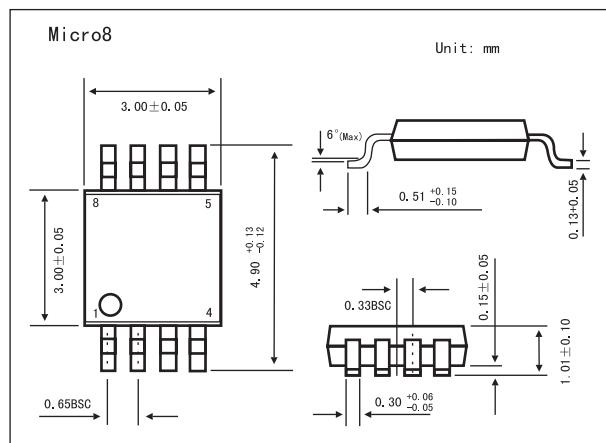
- Dual N and P Channel MOSFET

- Very Small SOIC Package

- Low Profile (<1.1mm)

- Available in Tape & Reel

- Fast Switching



#### ■ Absolute Maximum Ratings Ta = 25°C

Parameter	Symbol	N-Channel	P-Channel	Unit
Drain-Source Voltage	V <sub>DS</sub>	20	-20	V
Continuous Drain Current V <sub>GS</sub> Ta = 25°C	I <sub>D</sub>	2.4	-1.7	A
Continuous Drain Current V <sub>GS</sub> Ta = 70°C	I <sub>D</sub>	1.9	-1.4	
Pulsed Drain Current *1	I <sub>DM</sub>	21	-14	
Power Dissipation @Ta= 25°C	P <sub>D</sub>	1.25		W
Power Dissipation @Ta= 70°C		0.8		
Linear Derating Factor		10		mW/°C
Gate-to-Source Voltage	V <sub>GS</sub>	±12		V
Gate-to-Source Voltage Single Pulse t <sub>p</sub> <10 μ s	V <sub>GSM</sub>	16		V
Peak Diode Recovery dv/dt *2	dv/dt	5.0	-5.0	V/ ns
Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 to + 150		°C
Maximum Junction-to-Ambient*3	R <sub>θ JA</sub>	100		°C/W

\*1 Repetitive rating; pulse width limited by max. junction temperature.

\*2 N-Channel I<sub>SD</sub> ≤ 1.7A, di/dt ≤ 100A/ μ s, V<sub>DD</sub> ≤ V<sub>(BR)DSS</sub>, T<sub>J</sub> ≤ 150°C

P-Channel I<sub>SD</sub> ≤ -1.2A, di/dt ≤ 50A/ μ s, V<sub>DD</sub> ≤ V<sub>(BR)DSS</sub>, T<sub>J</sub> ≤ 150°C

\*3 Surface mounted on FR-4 board, t ≤ 10sec.

■ Electrical Characteristics  $T_J = 25^\circ\text{C}$ 

Parameter	Symbol	Testconditons		Min	Typ	Max	Unit
Drain-to-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{GS} = 0V, I_D = 250 \mu A$	N-Ch	20			V
		$V_{GS} = 0V, I_D = -250 \mu A$	P-Ch	-20			
Breakdown Voltage Temp. Coefficient	$\Delta V_{(\text{BR})\text{DSS}} / \Delta T_J$	$I_D = 1\text{mA}, \text{Reference to } 25^\circ\text{C}$	N-Ch		0.041		$\text{V}/^\circ\text{C}$
		$I_D = -1\text{mA}, \text{Reference to } 25^\circ\text{C}$	P-Ch		0.012		
Static Drain-to-Source On-Resistance	$R_{DS(\text{on})}$	$V_{GS} = 4.5V, I_D = 1.7A^*$	N-Ch	0.085	0.14		$\Omega$
		$V_{GS} = 2.7V, I_D = 0.85A^*$		0.120	0.20		
		$V_{GS} = -4.5V, I_D = -1.2A^*$	P-Ch	0.17	0.27		
		$V_{GS} = -2.7V, I_D = -0.6A^*$		0.28	0.40		
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250 \mu A$	N-Ch	0.7			V
		$V_{DS} = V_{GS}, I_D = -250 \mu A$	P-Ch	-0.7			
Forward Transconductance	$g_{fs}$	$V_{DS} = 10V, I_D = 0.85A^*$	N-Ch	2.6			S
		$V_{DS} = -10V, I_D = -0.6A^*$	P-Ch	1.3			
Drain-to-Source Leakage Current	$I_{DSS}$	$V_{DS} = 16V, V_{GS} = 0V$	N-Ch		1.0		$\mu A$
		$V_{DS} = -16V, V_{GS} = 0V$	P-Ch		-1.0		
		$V_{DS} = 16V, V_{GS} = 0V, T_J = 125^\circ\text{C}$	N-Ch		25		
		$V_{DS} = -16V, V_{GS} = 0V, T_J = 125^\circ\text{C}$	P-Ch		-25		
Gate-to-Source Forward Leakage	$I_{GSS}$	$V_{GS} = \pm 12V$	N-Ch		$\pm 100$		nA
			P-Ch		$\pm 100$		
Total Gate Charge	$Q_g$	N-Channel $I_D = 1.7A, V_{DS} = 16V, V_{GS} = 4.5V^*$ P-Channel $I_D = -1.2A, V_{DS} = -16V, V_{GS} = -4.5V^*$	N-Ch		5.3	8.0	nC
Gate-to-Source Charge	$Q_{gs}$		P-Ch		5.4	8.2	
Gate-to-Drain ("Miller") Charge	$Q_{gd}$		N-Ch		0.84	1.3	
Turn-On Delay Time	$t_{d(on)}$		P-Ch		0.96	1.4	
Rise Time	$t_r$		N-Ch		2.2	3.3	
Turn-Off Delay Time	$t_{d(off)}$		P-Ch		2.4	3.6	
Fall Time	$t_f$	N-Channel $V_{DD} = 10V, I_D = 1.7A, R_G = 6.0 \Omega$ P-Channel $R_D = 5.7 \Omega^* 1$ $V_{DD} = -10V, I_D = -1.2A, R_G = 6.0 \Omega$ $R_D = 8.3 \Omega^* 1$	N-Ch		5.7		ns
Input Capacitance	$C_{iss}$		P-Ch		9.1		
Output Capacitance	$C_{oss}$		N-Ch		24		
Reverse Transfer Capacitance	$C_{rss}$		P-Ch		35		
Continuous Source Current (Body Diode)	$I_S$		N-Ch		15		
Pulsed Source Current (Body Diode) *2	$I_{SM}$		P-Ch		38		
		N-Channel $V_{GS} = 0V, V_{DS} = 15V, f = 1.0\text{MHz}^*$ P-Channel $V_{GS} = 0V, V_{DS} = -15V, f = 1.0\text{MHz}^*$	N-Ch		16		pF
			P-Ch		43		
			N-Ch		260		
			P-Ch		240		
		N-Channel $V_{GS} = 0V, V_{DS} = 15V, f = 1.0\text{MHz}^*$ P-Channel $V_{GS} = 0V, V_{DS} = -15V, f = 1.0\text{MHz}^*$	N-Ch		130		pF
			P-Ch		130		
			N-Ch		61		
			P-Ch		64		
			N-Ch			1.25	A
			P-Ch			-1.25	
			N-Ch			19	
			P-Ch			-14	

**KRF7507**■ Electrical Characteristics  $T_J = 25^\circ\text{C}$ 

Parameter	Symbol	Testconditons		Min	Typ	Max	Unit
Diode Forward Voltage	$V_{SD}$	$T_J = 25^\circ\text{C}, I_S = 1.7\text{A}, V_{GS} = 0\text{V}$ <sup>*1</sup>	N-Ch			1.2	V
		$T_J = 25^\circ\text{C}, I_S = -1.2\text{A}, V_{GS} = 0\text{V}$ <sup>*1</sup>	P-Ch			-1.2	
Reverse Recovery Time	$t_{rr}$	N-Channel	N-Ch		39	59	ns
		$T_J = 25^\circ\text{C}, I_F = 1.7\text{A}, dI/dt = 100\text{A}/\mu\text{s}$ <sup>*1</sup>	P-Ch		52	78	
Reverse Recovery Charge	$Q_{rr}$	P-Channel	N-Ch		37	56	nC
		$T_J = 25^\circ\text{C}, I_F = -1.2\text{A}, dI/dt = -100\text{A}/\mu\text{s}$ <sup>*1</sup>	P-Ch		63	95	

\*1 Pulse width  $\leq 300 \mu\text{s}$ ; duty cycle  $\leq 2\%$ .

\*2 Repetitive rating; pulse width limited by max. junction temperature.